

Features

- Easy paralleling capability due to positive temperature coefficient in V_{CESAT}
- Low EMI
- Rugged Transient Reliability
- Low saturation voltage $V_{CE(SAT)}$
- Low Switching Losses
- RoHS compliant with Halogen-free

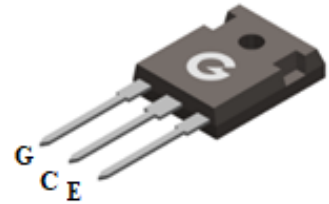
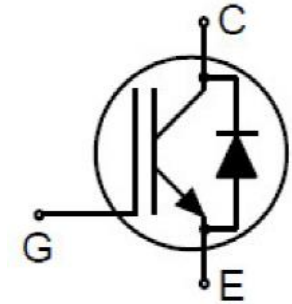
Applications

- Inductive Cooking
- Inverterized Microwave Ovens
- Resonant Converters
- Soft Switching Applications

HF

Mechanical Data

- Case: TO-247
- Molding Compound: UL Flammability Classification Rating 94V-0
- Terminals: Matte tin-plated leads; solderability-per MIL-STD-202, Method 208



TO-247

Ordering Information

Part Number	Package	Shipping Quantity	Marking Code
GHU20N135R5	TO-247	30 pcs / Tube	KU20N135R5

Maximum Ratings (@ $T_C = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Collector-to-Emitter Voltage	V_{CES}	1350	V
Gate-Emitter Voltage	V_{GES}	± 20	V
DC Collector Current ($T_C = 25^\circ\text{C}$, limited by maximum T_J)	I_C	40	A
DC Collector Current ($T_C = 100^\circ\text{C}$, limited by maximum T_J)		20	A
Diode Continuous Forward Current ($T_C = 25^\circ\text{C}$, limited by maximum T_J)	I_F	40	A
Diode Continuous Forward Current ($T_C = 100^\circ\text{C}$, limited by maximum T_J)		20	A
Pulsed Collector Current (Pulse width limited by maximum T_J , $V_{GE} = 15\text{V}$)	I_{CM}	60	A
Pulsed Source-Drain Current (Pulse width limited by maximum T_J)	I_{FM}	60	A
Soldering Temperature, Wave Soldering 1.6mm (0.063in.) from case for 10s	T_{sold}	260	$^\circ\text{C}$
Power Dissipation ($T_C = 25^\circ\text{C}$)	P_D	241	W
Operating Junction Temperature Range	T_J	$-55 \sim +175$	$^\circ\text{C}$
Storage Temperature Range	T_{STG}	$-55 \sim +175$	$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal Resistance Junction-to-Case, IGBT	$R_{\theta JC}$	-	0.62	-	$^{\circ}\text{C/W}$
Thermal Resistance Junction-to-Air	$R_{\theta JA}$	-	15	-	$^{\circ}\text{C/W}$

Electrical Characteristics of the IGBT (@ $T_J = 25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
V _{(BR)CES}	Collector-Emitter Breakdown Voltage	V _{GE} = 0V, I _C = 250μA	1350	-	-	V
I _{CES}	Collector-Emitter Leakage Current	V _{CE} = 1350V, V _{GE} = 0V	-	-	1	μA
I _{GES}	Gate to Emitter Leakage Current	V _{GE} = ±20V, V _{CE} = 0V	-	-	±100	nA
V _{CE(sat)}	Collector-Emitter Saturation Voltage	V _{GE} = 15V, I _C = 20A, T _J = 25°C	-	1.66	-	V
		V _{GE} = 15V, I _C = 20A, T _J = 175°C	-	2.15	-	V
V _{GE(th)}	Gate Threshold Voltage	V _{CE} = V _{GE} , I _C = 250μA	5	5.9	6.8	V
R _G	Gate Resistance	V _{GS} = 0V, f = 1MHz	-	1.2	-	Ω
Dynamic Characteristics						
Q _G	Total Gate-Charge	V _{CC} = 600V, V _{GE} = 15V, I _C = 20A	-	68	-	nC
C _{ies}	Input Capacitance	V _{CE} = 25V	-	2038	-	pF
C _{oes}	Output Capacitance	V _{GE} = 0V	-	29	-	
C _{res}	Reverse Transfer Capacitance	f = 100kHz	-	9	-	
Switching Characteristics						
t _{d(on)}	Turn-on Delay Time	V _{CE} = 600V V _{GE} = 15V I _C = 25A R _G = 10Ω T _J = 25°C	-	69	-	ns
t _r	Turn-on Rise Time		-	71	-	
t _{d(off)}	Turn-Off Delay Time		-	95	-	
t _f	Turn-Off Fall Time		-	150	-	
E _{on}	Turn-On Switching Loss		-	1.37	-	mJ
E _{off}	Turn-Off Switching Loss		-	1.17	-	

Electrical Characteristics of the Diode (@ $T_J = 25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
Dynamic Characteristics						
V_{FM}	Diode Forward Voltage	$I_F = 20A, V_{GE} = 0V$	-	1.9	-	V

Ratings and Characteristics Curves (@ $T_A = 25^\circ\text{C}$ unless otherwise specified)

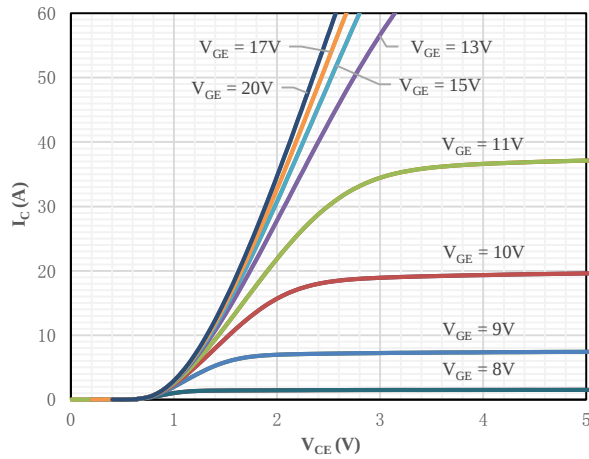


Fig 1 Typical Output Characteristics

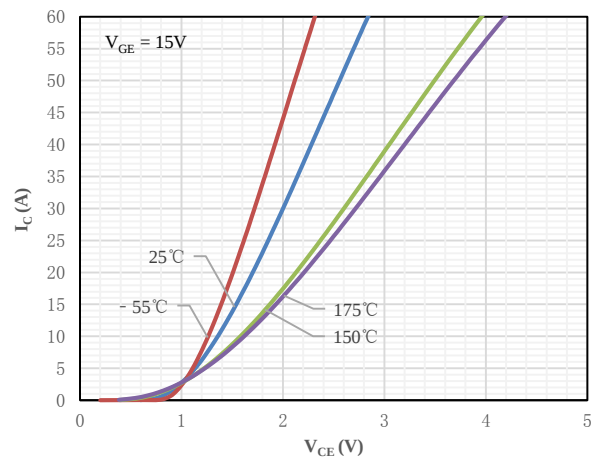


Fig 2 Saturation Voltage Characteristics

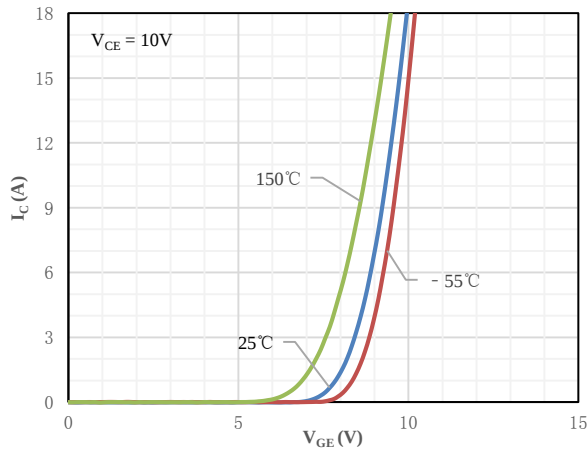


Fig 3 Transfer Characteristics

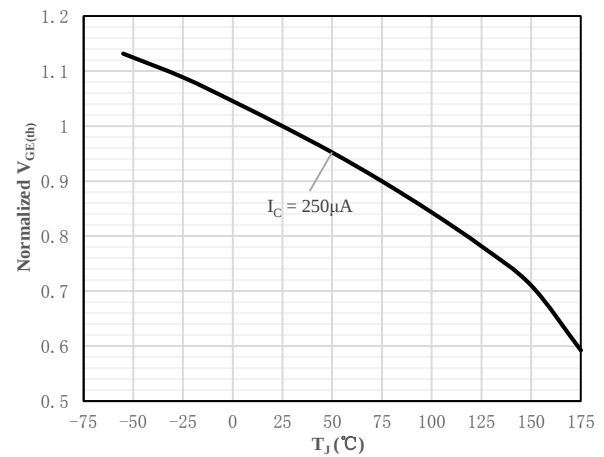


Fig 4 Normalized $V_{GE(th)}$ vs. Junction Temperature

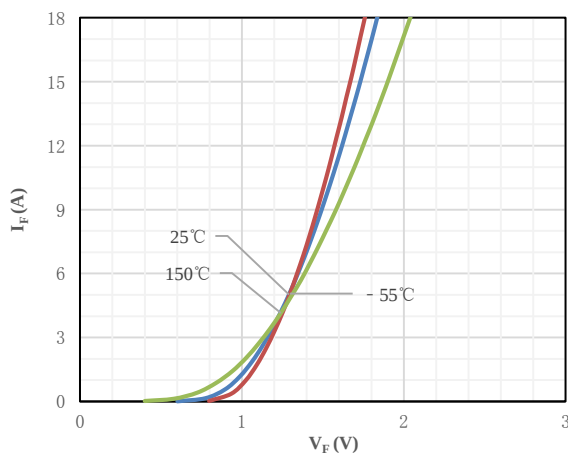


Fig 5 Diode forward current as a function of forward voltage V_F vs. I_F

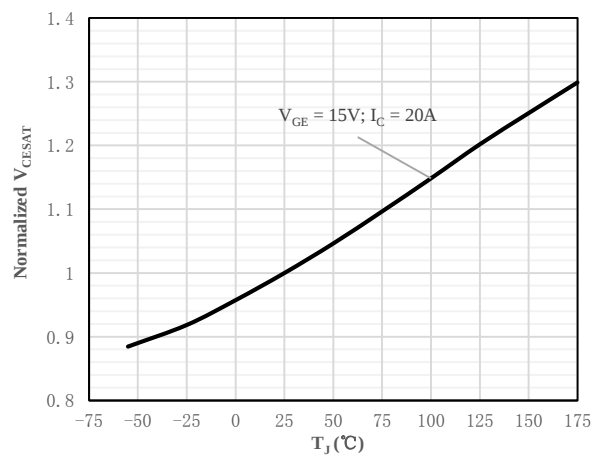


Fig 6 Normalized Collector-Emitter Saturation Voltage vs. Junction Temperature

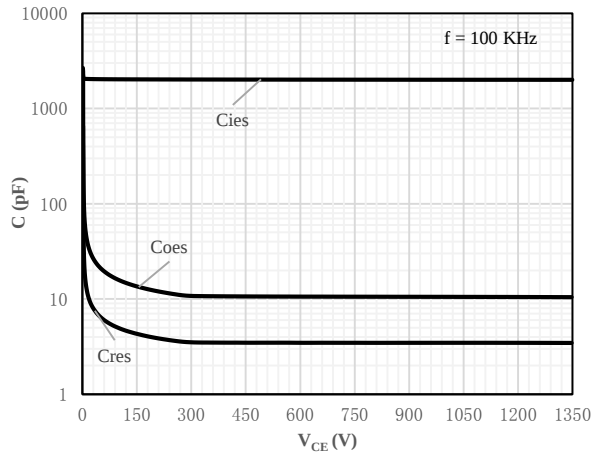


Fig 7 Capacitance Characteristics

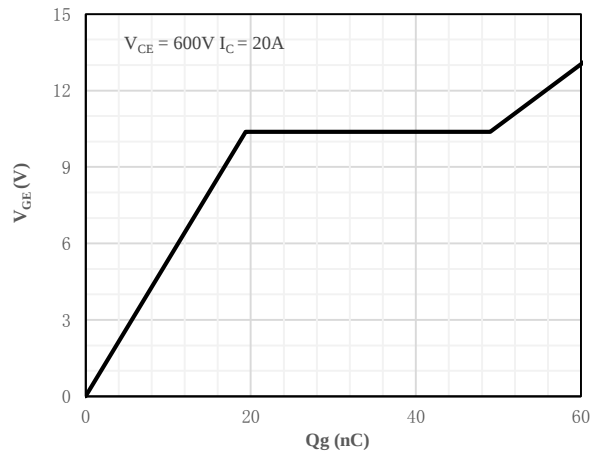


Fig 8 Gate-Charge Characteristics

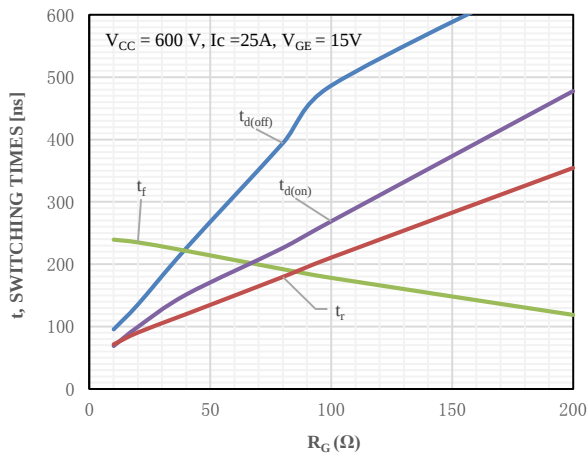


Fig 9 Switching Times vs. Gate Resistor

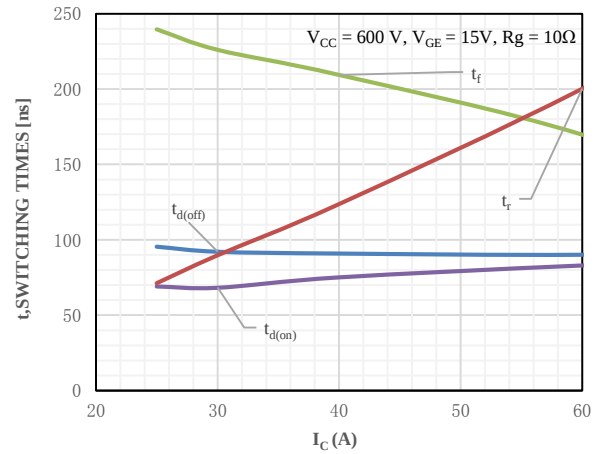


Fig 10 Switching Times vs. Collector Current

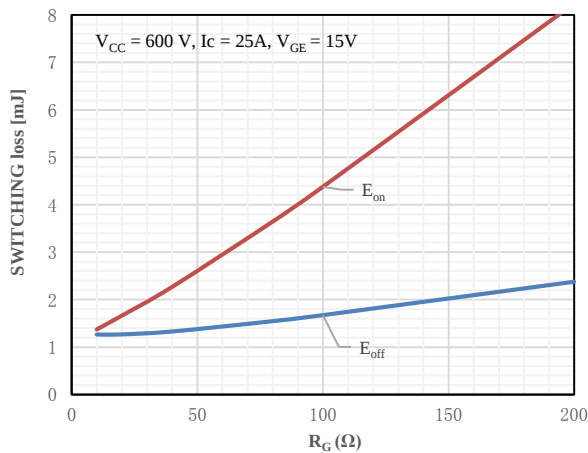


Fig 11 Switching Loss vs. Gate Resistor

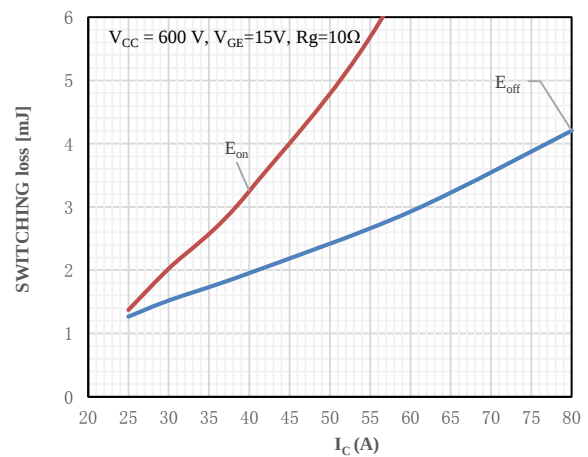


Fig 12 Switching Loss vs. Collector Current

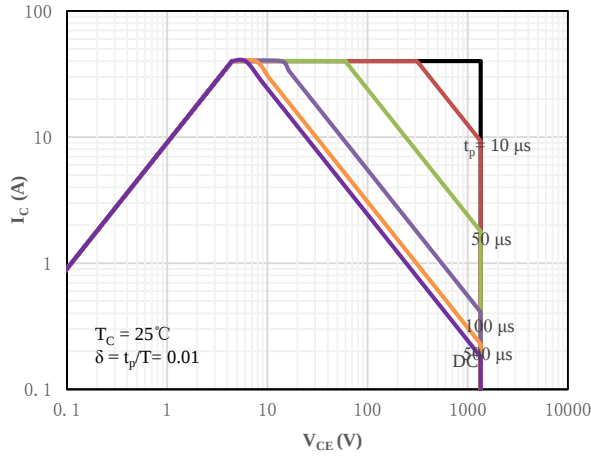


Fig 13 SOA characteristics

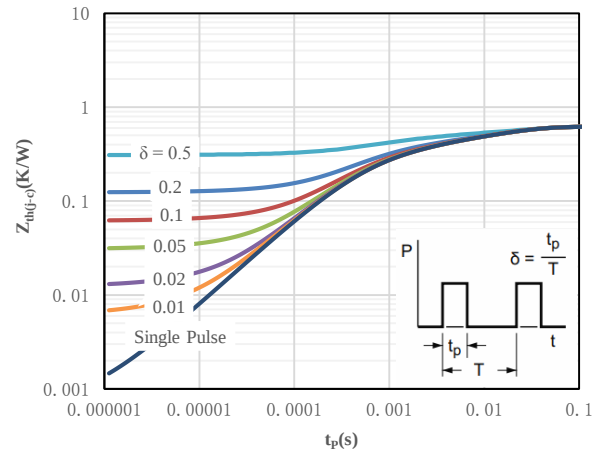


Fig 14 Maximum transient thermal impedance

Waveform definitions

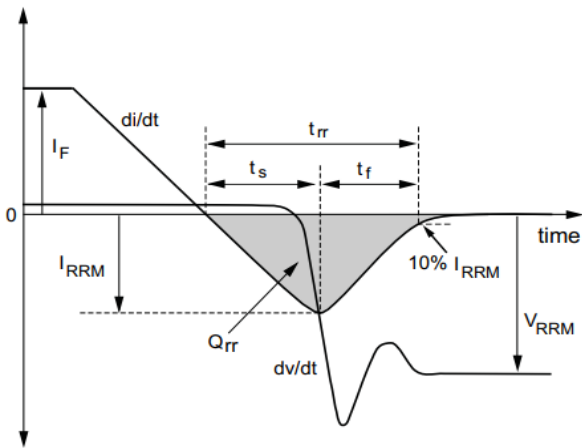


Fig 1 Diode Reverse Recovery Waveform Definitions

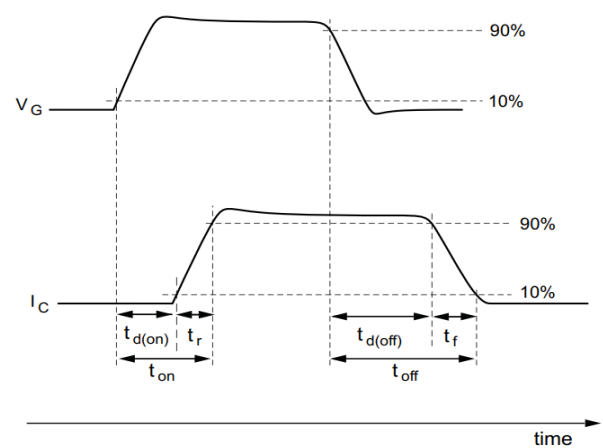


Fig 2 IGBT Switching Times Definitions

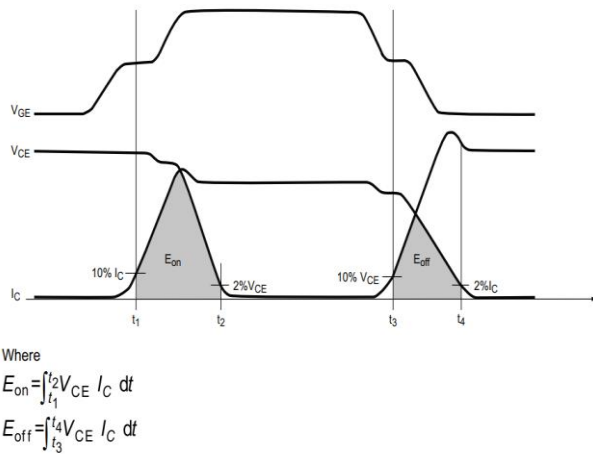
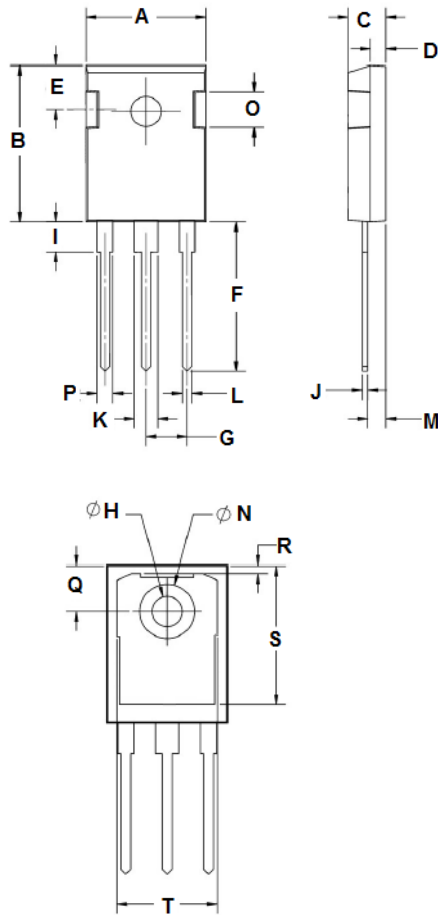


Fig 3 IGBT Switching Energy Loss Definitions

Package Outline Dimensions (Unit: mm)



TO-247		
Dimension	Min.	Max.
A	15.50	16.10
B	20.70	21.30
C	4.70	5.30
D	1.80	2.20
E	5.20	5.80
F	19.70	20.30
G	5.20	5.60
H	3.30	3.70
I	3.90	4.30
J	0.50	0.70
K	2.80	3.20
L	1.00	1.40
M	2.20	2.60
N	7.00	7.20
O	4.90	5.30
P	1.80	2.20
Q	5.70	5.90
R	0.80	1.20
S	17.00	17.80
T	13.60	14.20